

SGM48524D Dual 5A, High-Speed, Low-Side Gate Driver with Negative Input Voltage Capability

GENERAL DESCRIPTION

The SGM48524D is a dual high-speed low-side gate driver for power switches. It has rail-to-rail driving capability and can sink or source up to 5A peak current with capacitive loads. The propagation delays are very short and well matched between the two channels that make the device well suited for applications that need accurate dual gate driving such as synchronous rectifiers. The matched propagation delays also allow for paralleling the two channels when higher driving current is required (such as for paralleled switches). The input voltage thresholds are fixed, independent of supply voltage (V_{DD}), and compatible with low voltage TTL and CMOS logic. Noise immunity is excellent due to the wide hysteresis window between the input low and high thresholds. The device has internal pull-up/pull-down resistors on the input pins to ensure low state on the driver output when the input is floating.

The SGM48524D is available in Green SOIC-8, TDFN-3×3-8L and MSOP-8 (Exposed Pad) packages.

APPLICATIONS

DC/DC Converters Solar Power, Motor Drivers Switched-Mode Power Supplies Gate Drive for Emerging Wide Bandgap Devices

FEATURES

- Two Independent Gate Drive Channels
- 5A Source and 5A Sink Peak Currents
- Wide Supply Voltage Range: 4.5V to 18V
- TTL and CMOS Compatible Logic Threshold
- Logic Levels Independent of Supply Voltage
- Hysteretic Input Logic for High Noise Immunity
- Outputs Held Low when Inputs are Floating
- Fast Propagation Delays: 18ns (TYP)
- Fast Rise Time: 7ns (TYP)
- Fast Fall Time: 7ns (TYP)
- Ringing Suppression
- Negative Voltage Capability on INx Pins:
 -10V when (V_{DD} V_{INx}) ≤ 20V
- Negative Voltage Capability on ENx Pins:
 -10V when (V_{DD} V_{ENx}) ≤ 20V
- Negative Voltage Capability on OUTx Pin: -2V (Pulse < 200ns)
- Protection Features
 - Thermal Shutdown Protection
 - Under-Voltage Lockout
- -40°C to +140°C Operating Temperature Range
- Available in Green SOIC-8, MSOP-8 (Exposed Pad) and TDFN-3×3-8L Packages



SGM48524D

PACKAGE/ORDERING INFORMATION

MODEL	PACKAGE DESCRIPTION	SPECIFIED TEMPERATURE RANGE	ORDERING NUMBER	PACKAGE MARKING	PACKING OPTION
	SOIC-8	-40°C to +140°C	SGM48524DXS8G/TR	SGM 48524DXS8 XXXXX	Tape and Reel, 4000
SGM48524D	MSOP-8 (Exposed Pad)	-40°C to +140°C	SGM48524DXPMS8G/TR	SGM03F XPMS8 XXXXX	Tape and Reel, 4000
	TDFN-3×3-8L	-40°C to +140°C	SGM48524DXTDB8G/TR	SGM 03CDB XXXXX	Tape and Reel, 4000

MARKING INFORMATION

NOTE: XXXXX = Date Code, Trace Code and Vendor Code.

Х	Х	Х	Х	Х
		_		_

Vendor Code

- Trace Code

- Date Code - Year

Green (RoHS & HSF): SG Micro Corp defines "Green" to mean Pb-Free (RoHS compatible) and free of halogen substances. If you have additional comments or questions, please contact your SGMICRO representative directly.

ABSOLUTE MAXIMUM RATINGS

VDD
Continuous INA, INB when $(V_{DD} - V_{INx}) \le 20V$
10V to V_{DD} + 0.3V
Continuous ENA, ENB when $(V_{DD} - V_{ENx}) \le 20V$
10V to V_{DD} + 0.3V
Continuous OUTA, OUTB (DC)0.3V to V_{DD} + 0.3V
Pulse OUTA, OUTB (Pulse < 200ns)2V to V_{DD} + 0.3V
Package Thermal Resistance
SOIC-8, θ _{JA}
MSOP-8 (Exposed Pad), θ _{JA} 55°C/W
TDFN-3×3-8L, θ_{JA}
Junction Temperature+150°C
Storage Temperature Range65°C to +150°C
Lead Temperature (Soldering, 10s)+260°C
ESD Susceptibility
HBM7000V
CDM

RECOMMENDED OPERATING CONDITIONS

Supply Voltage Range	4.5V to 18V
Operating Junction Temperature Range	-40°C to +140°C

OVERSTRESS CAUTION

Stresses beyond those listed in Absolute Maximum Ratings may cause permanent damage to the device. Exposure to absolute maximum rating conditions for extended periods may affect reliability. Functional operation of the device at any conditions beyond those indicated in the Recommended Operating Conditions section is not implied.

ESD SENSITIVITY CAUTION

This integrated circuit can be damaged if ESD protections are not considered carefully. SGMICRO recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage. ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because even small parametric changes could cause the device not to meet the published specifications.

DISCLAIMER

SG Micro Corp reserves the right to make any change in circuit design, or specifications without prior notice.



PIN CONFIGURATIONS



PIN DESCRIPTION

PIN	NAME	I/O	FUNCTION
1	ENA	Ι	Channel A Enable Input. Pull ENA high or leave it floating to enable OUTA output. Pull ENA low to disable OUTA output, ignoring INA state.
2	INA	Ι	Non-Inverting Input to Channel A. OUTA is held low if INA is unbiased or left floating.
3	GND		Ground. Reference pin for all signals.
4	INB	Ι	Non-Inverting Input to Channel B. OUTB is held low if INB is unbiased or left floating.
5	OUTB	0	Channel B Output.
6	VDD	I	Power Supply Input.
7	OUTA	0	Channel A Output.
8	ENB	I	Channel B Enable Input. Pull ENB high or leave it floating to enable OUTB output. Pull ENB low to disable OUTB output, ignoring INB state.
Exposed Pad	GND	_	Exposed Pad. It is internally connected to GND. Connect it to a large ground plane to maximize thermal performance; not intended as an electrical connection point.

NOTE: I: input, O: output.

FUNCTION TABLE

ENA	ENB	INA	INB	OUTA	OUTB
Н	Н	L	L	L	L
н	Н	L	Н	L	Н
Н	Н	Н	L	Н	L
Н	Н	Н	Н	Н	Н
L	L	Any	Any	L	L
Any	Any	Floating	Floating	L	L
Floating	Floating	L	L	L	L
Floating	Floating	L	Н	L	Н
Floating	Floating	Н	L	Н	L
Floating	Floating	Н	Н	Н	Н

TYPICAL APPLICATION



Figure 1. Typical Application Circuit



ELECTRICAL CHARACTERISTICS

 $(V_{DD} = 12V, C_{IN} = 4.7\mu$ F, $T_J = -40$ °C to +140°C, typical values are at $T_J = +25$ °C, unless otherwise noted.)

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS
Power Supplies	I					
VDD Operating Supply Voltage	V _{DD}		4.5		18	V
		V_{DD} = 3.4V, V_{INA} = V_{INB} = GND		75	119	
VDD Operating Supply Current	I _{DD}	V_{DD} = 3.4V, V_{INA} = V_{INB} = V_{DD}		110	171	μA
		INx and ENx floating		285	447	
	V _{ON}		3.9	4.15	4.45	V
VDD Under-Voltage Lockout Voltage	V _{OFF}		3.65	3.9	4.2	V
Supply Voltage Hysteresis	V _{HYS}		0.15	0.25	0.35	V
Inputs (INA, INB)				•	•	
Input Signal High Threshold	V _{IN_H}		1.9	2.1	2.3	V
Input Signal Low Threshold	V _{IN_L}		1	1.2	1.4	V
Input Hysteresis	V _{IN_HYS}		0.7	0.9	1.1	V
Input Low Current	IIL	V _{DD} = 18V, T _J = +25°C		0.1	1	μA
Input High Current	I _{IH}	V _{DD} = 18V, T _J = +25°C		100	135	μA
Enable (ENA, ENB)				•	•	
Enable Signal High Threshold	$V_{\text{EN}_{\text{H}}}$		1.9	2.1	2.3	V
Enable Signal Low Threshold	$V_{\text{EN}_{L}}$		1	1.2	1.4	V
Enable Hysteresis	$V_{\text{EN}_{\text{HYS}}}$		0.7	0.9	1.1	V
Enable Low Current	I _{ENL}	V _{DD} = 18V, T _J = +25°C		96	130	μA
Enable High Current	I _{ENH}	V _{DD} = 18V, T _J = +25°C		1.9	10	μA
Outputs (OUTA, OUTB)						
Output Pull-Up Resistance ⁽¹⁾	R _{OH}	I _{OUT} = 10mA		4.6	7.2	Ω
Output Pull-Down Resistance	R _{oL}	I _{OUT} = -10mA		465	800	mΩ
Deels Output Current	I _{PK_SOURCE}			5		А
	I _{PK_SINK}	$C_L = 0.22\mu$ F, $I_{SW} = 1$ KHZ		5		А
Switching Characteristics						
Rise Time	t _R	C_L = 1.8nF, see Figure 2 and Figure 3		7		ns
Fall Time	t _F	C_L = 1.8nF, see Figure 2 and Figure 3		7		ns
Delay Matching between 2 Channels	t _M	INA = INB, OUTA and OUTB at 50% transition point		1		ns
Input to Output Propagation Delay	t _{D1} , t _{D2}	C_L = 1.8nF, 4V input pulse, see Figure 2		18		ns
EN to Output Propagation Delay	t_{D3}, t_{D4}	C_L = 1.8nF, 4V enable pulse, see Figure 3		18		ns
Protection Circuits						
Thermal Shutdown Temperature	T _{TSD}			165		°C
Thermal Shutdown Temperature Hysteresis	T _{HYS}			25		°C

NOTE:

1. R_{OH} represents constant pull-up resistance only. Pull-up resistance R_{OH_PULSE} operates in pulse mode during the output rising stage, $R_{OH_PULSE} = 730 m\Omega$ (TYP).

TYPICAL PERFORMANCE CHARACTERISTICS

 V_{DD} = 12V, C_{IN} = 4.7µF, unless otherwise noted.













TYPICAL PERFORMANCE CHARACTERISTICS (continued)

 V_{DD} = 12V, C_{IN} = 4.7µF, unless otherwise noted.



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TYPICAL PERFORMANCE CHARACTERISTICS (continued)

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SGM48524D

Dual 5A, High-Speed, Low-Side Gate Driver with Negative Input Voltage Capability

TIMING DIAGRAMS



Figure 2. Non-Inverting Input Driver Operation



FUNCTIONAL BLOCK DIAGRAM



Figure 4. Functional Block Diagram



SGM48524D

DETAILED DESCRIPTION

As a dual-channel, low-side, high-speed gate driver, the SGM48524D is among the top level devices in the market featuring 5A source/sink current capability and industry best-in-class switching characteristics. It has several other prominent features as listed in Table 1 assuring that they are reliable and efficient gate driving solutions for power switches in high frequency applications.

VDD and Under-Voltage Lockout

The internal under-voltage lockout (UVLO) protection keeps the outputs in low state when the VDD supply voltage is insufficient for proper operation of the chip. If V_{DD} is rising but its level is still below UVLO threshold, the outputs are held low, ignoring the state of the inputs. The UVLO rising threshold level is 4.15V (TYP) and has a 250mV (TYP) hysteresis band to prevent output from chattering when V_{DD} is low and prone to droops, large superimposed noise or other fluctuations.

Because VDD pin is the supply source for the device internal circuits, it is recommended to use two V_{DD} surface mount bypass capacitors to prevent noise problems due to high speed switching. A small 100nF

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ceramic capacitor must be soldered between the VDD and GND pins as close as possible. In addition, a larger low ESR capacitor (at least 4.7μ F) must be placed in parallel and close to the same pins for delivery of the high peak driving currents with sharp rise time. The low impedance characteristic provided by these capacitors allows high frequency and high current driving of the outputs. Avoid using vias for connecting bypass capacitors to the device pins.

Protection and Ringing Suppression

The SGM48524D is a reliable and high-speed gate driver for power switches with a comprehensive set of protection features such as thermal shutdown protection (TSD) and under-voltage lockout (UVLO). Both TSD and UVLO are active. The outputs will be forced low when any threshold of the above two protections is reached and held low during hysteresis range. Only if both TSD and UVLO are released, the outputs follow the inputs again.

The SGM48524D offers a unique output stage design. It can effectively suppress the output voltage ringing and the overshoot/undershoot on the outputs.

Features	Benefits
Best-in-class propagation delay (18ns, TYP).	Very low delay and distortion in pulse transmission.
Excellent delay matching between channels (1ns, TYP).	Allow paralleling of the channel outputs for double current driving capability. It is especially useful for driving paralleled power switches.
Wide supply operating range (V_{DD} from 4.5V to 18V).	Design Flexibility.
Wide operating temperature range (-40°C to +140°C).	Wider system operating temperature range and smaller cooling system.
UVLO protection on VDD.	Driver outputs are actively held low in UVLO condition to ensure controlled and glitch-free driving during power-up and power-down.
Outputs are actively held low when inputs (INx) are floating.	This safety feature prevents unexpected gate pulses during abnormal situations such as the conditions tested in the safety certification.
Outputs are enabled when enable inputs (ENx) are floating.	This feature provides pin-to-pin compatibility with other similar products in those designs where pin 1 and 8 are floating.
Wide hysteresis CMOS/TTL compatible input and enable thresholds.	Improved noise immunity while compatible with digital logic.
Input/enable pin voltage levels are not restricted by $V_{\mbox{\tiny DD.}}$	Simplified system especially in the auxiliary bias supply architecture.
Ringing Suppression	Reduce turn-on/off overshoot/undershoot amplitude and period.

REVISION HISTORY

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

MARCH 2023 – REV.A to REV.A.1	Page
Changed Package/Ordering Information section	
Changed Electrical Characteristics section	5
Changed Typical Performance Characteristics section	6, 7, 8
Changes from Original (OCTOBER 2022) to REV.A	Page
Changed from product preview to production data	All



PACKAGE OUTLINE DIMENSIONS SOIC-8





RECOMMENDED LAND PATTERN (Unit: mm)





Symbol	Dimensions In Millimeters		Dimensions In Inches		
	MIN	MAX	MIN	MAX	
A	1.350	1.750	0.053	0.069	
A1	0.100	0.250	0.004	0.010	
A2	1.350	1.550	0.053	0.061	
b	0.330	0.510	0.013	0.020	
С	0.170	0.250	0.006	0.010	
D	4.700	5.100	0.185	0.200	
E	3.800	4.000	0.150	0.157	
E1	5.800	6.200	0.228	0.244	
е	1.27 BSC		0.050 BSC		
L	0.400	1.270	0.016	0.050	
θ	0°	8°	0°	8°	

NOTES:

Body dimensions do not include mode flash or protrusion.
 This drawing is subject to change without notice.



PACKAGE OUTLINE DIMENSIONS

MSOP-8 (Exposed Pad)





RECOMMENDED LAND PATTERN (Unit: mm)





Symbol	Dimer In Milli	nsions meters	Dimensions In Inches	
	MIN	MAX	MIN	MAX
A	0.820	1.100	0.032	0.043
A1	0.020	0.150	0.001	0.006
A2	0.750	0.950	0.030	0.037
b	0.250	0.380	0.010	0.015
С	0.090	0.230	0.004	0.009
D	2.900	3.100	0.114	0.122
D1	1.700	1.900	0.067	0.075
е	0.65	BSC	0.026 BSC	
E	2.900	3.100	0.114	0.122
E1	4.750	5.050	0.187	0.199
E2	1.450	1.650	0.057	0.065
L	0.400	0.800	0.016	0.031
θ	0°	6°	0°	6°

NOTES:

Body dimensions do not include mode flash or protrusion.
 This drawing is subject to change without notice.



PACKAGE OUTLINE DIMENSIONS

TDFN-3×3-8L



RECOMMENDED LAND PATTERN (Unit: mm)

Symbol	Dimer In Milli	nsions meters	Dimensions In Inches		
	MIN	MAX	MIN	MAX	
А	0.700	0.800	0.028	0.031	
A1	0.000	0.050	0.000	0.002	
A2	0.203	B REF	0.008 REF		
D	2.900	3.100	0.114	0.122	
D1	2.200	2.400	0.087	0.094	
E	2.900	3.100	0.114	0.122	
E1	1.400	1.600	0.055	0.063	
k	0.200 MIN		0.008 MIN		
b	0.180	0.300	0.007	0.012	
е	0.650) TYP	0.026 TYP		
L	0.375	0.575	0.015	0.023	

NOTE: This drawing is subject to change without notice.



TAPE AND REEL INFORMATION

REEL DIMENSIONS



NOTE: The picture is only for reference. Please make the object as the standard.

Package Type	Reel Diameter	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P0 (mm)	P1 (mm)	P2 (mm)	W (mm)	Pin1 Quadrant
SOIC-8	13″	12.4	6.40	5.40	2.10	4.0	8.0	2.0	12.0	Q1
MSOP-8 (Exposed Pad)	13″	12.4	5.20	3.30	1.50	4.0	8.0	2.0	12.0	Q1
TDFN-3×3-8I	13″	12.4	3.35	3.35	1.13	4.0	8.0	2.0	12.0	Q1

KEY PARAMETER LIST OF TAPE AND REEL

DD0001

CARTON BOX DIMENSIONS



NOTE: The picture is only for reference. Please make the object as the standard.

KEY PARAMETER LIST OF CARTON BOX

Reel Type	Length (mm)	Width (mm)	Height (mm)	Pizza/Carton]_
13″	386	280	370	5	00002

